

Cascadable 64K x 9 FIFO Cascadable 128K x 9 FIFO

Features

- 64K x 9 FIFO buffer memory (4208) or 128K x 9 FIFO buffer memory (4209)
- · Asynchronous read/write
- High-speed, 28.5-MHz read/write
- Pin-compatible with standard, 28-pin monolithic FIFOs
- Low operating power
 - $-I_{CC}$ (max.) = 640 mA (commercial)
- 600-mil DIP package
- · Empty, Full flags
- Small PCB footprint
 - 0.88 sq. in.
- · Expandable in depth and width

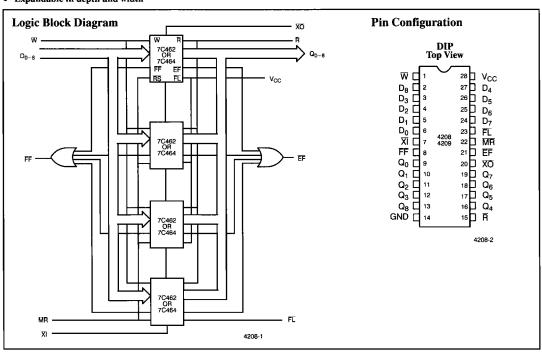
Functional Description

The CYM4208 is a first-in first-out (FIFO) memory module that is 64K words by 9 bits wide. The CYM4209 is 128K words by 9 bits wide. Each is offered in a 600-mil-wide DIP package. Each FIFO memory is organized such that the data is read in the same sequential order that it was written. Full and Empty flags are provided to prevent overrun and underrun. Three additional pins are also provided to facilitate unlimited expansion in width, depth, or both. The depth expansion technique steers the control signals from one device to another in parallel, thus eliminating the serial addi-

tion of propagation delays so that throughput is not reduced. Data is steered in a similar manner.

The read and write operations may be asynchronous; each can occur at a rate of 28.5 MHz. The write operation occurs when the write (\overline{W}) signal is LOW. Read occurs when read (\overline{R}) goes LOW. The nine data outputs go to the high-impedance state when \overline{R} is HIGH.

In the depth expansion configuration the (\overline{XO}) pin provides the expansion out information that is used to tell the next FIFO that it will be activated.



Selection Guide

Deserving Carter							
	4208-25 4209-25	4208-30 4209-30	4208-40 4209-40				
Frequency (MHz)		28.5	25	20			
Access Time (ns)		25	30	40			
Maximum Operating Current (mA)	Commercial	640	640	640			
	Military		720	720			



Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Operating Range

Range	Ambient Temperature	v _{cc} _
Commercial	0°C to +70°C	5V ± 10%
Industrial	- 40°C to +85°C	5V ± 10%
Military ^[1]	− 55°C to +125°C	5V ± 10%

Electrical Characteristics Over the Operating Range

		Test Conditions			4208 4209	
Parameters	Description				Max.	Units
V _{OH}	Output HIGH Voltage	V_{CC} = Min., I_{OH} = -2.0 mA		2.4		V
V _{OL}	Output LOW Voltage	$V_{CC} = Min., I_{OL} = 8.0 \text{ mA}$			0.4	V
$V_{IH}^{[2]}$	Input HIGH Voltage		Com'l	2.0	V_{CC}	V
			Mil/Ind	2.2	V _{CC}	V
V _{IL}	Input LOW Voltage		•	- 0.5	0.8	V
I _{UX}	Input Current	$GND \leq V_{IN} \leq V_{CC}$		-10	+10	μА
I _{OZ}	Output Leakage Current	$\overline{R} \ge V_{IH}, GND \le V_O \le V_{CC}$		-10	+10	μΑ
I _{CC}	Operating Current	$V_{CC} = Max., I_{OUT} = 0 \text{ mA},$			640	mA
		f _{MAX} , Outputs Open	Mil/Ind		720	
I _{SB1}	Standby Current	All Inputs = V_{IH} Min., V_{CC} = Max.,	Com'l		100	mA
		f_{MAX} , $I_{OUT} = 0 \text{ mA}$	Mil/Ind		120	1
I _{SB2}	Power-Down Current	All Inputs, $V_{CC} - 0.2 \le V_{IN} \le 0.2$, $V_{CC} = Max$, $I_{OUT} = 0$, $f = 0$	Com'l		80	mA
		$V_{CC} = Max., I_{OUT} = 0, f = 0$			100	1

Capacitance

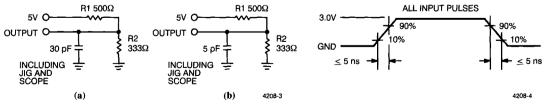
Parameters	Description	Test Conditions	Max.	Units
C _{IN}	Input Capacitance	$T_A = 25$ °C, $f = 1$ MHz, $V_{CC} = 4.5$ V	30	pF
C _{OUT}	Output Capacitance	VCC - 4.5 V	30	pF

Notes

1. TA is the "instant on" case temperature.

2. \overline{XI} must use CMOS levels with $V_{IH} \ge 3.5 V$ (CYM4209 only).

AC Test Loads and Waveforms





Switching Characteristics Over the Operating Range [3, 4, 5]

		Spec	Spec25		Spec30		Spec40	
Parameters	Description	Min.	Max.	Min.	Max.	Min.	Max.	Units
t _{RC}	Read Cycle Time	35		40		50		ns
t _A	Access Time	-	25		30		40	ns
t _{RR}	Read Recovery Time	10		10		10		ns
t _{PR}	Read Pulse Width	25		30		40		ns
t _{LZR}	Read LOW to Low Z	3		3		3		ns
t _{DVR}	Read HIGH to Data Valid	3		3		3		ns
t _{HZR}	Read HIGH to High Z		18		20		25	ns
twc	Write Cycle Time	35		40		50		ns
t _{PW}	Write Pulse Width	25		30		40		ns
t _{HWZ}	Write HIGH to Low Z	10		10		10		ns
twR	Write Recovery Time	10		10		10		ns
t_{SD}	Data Set-Up Time	18		18		20		ns
t _{HD}	Data Hold Time	0		0		0		ns
t _{MRSC}	MR Cycle Time	35		40		50		ns
t _{PMR}	MR Pulse Width	25		30		40		ns
t _{RMR}	MR Recovery Time	10		10		10		ns
t _{RPW}	Read HIGH to MR HIGH	25		30		40		ns
twpw	Write HIGH to MR HIGH	25		30		40		ns
t _{EFL}	MR to EF LOW		35		40		50	ns
t _{FFH}	MR to FF HIGH		35		40		50	ns
t _{REF}	Read LOW to EF LOW		25	ļ	30		40	ns
t _{RFF}	Read HIGH to FF HIGH		25		30		40	ns
tweF	Write HIGH to EF HIGH		25		30		40	ns
t _{WFF}	Write LOW to FF LOW		25		30		40	ns
t _{RAE}	Effective Read from Write HIGH		25		30		40	ns
t _{RPE}	Effective Read Pulse Width After EF HIGH	25		30		40		ns
twAF	Effective Write from Read HIGH		25		30		40	ns
twpF	Effective Write Pulse Width After FF HIGH	25		30		40		ns
t _{XOL}	Expansion Out LOW Delay from Clock		25		30		40	ns
t _{XOH}	Expansion Out HIGH Delay from Clock		25		30		40	ns

Notes: 3. Tes

Test conditions assume signal transition time of 5 ns or less, timing reference levels of 1.5V, and output loading of the specified I_{OL}/I_{OH} and 30-pF load capacitance, as in part (a) of AC Test Loads and Waveforms, unless otherwise specified.

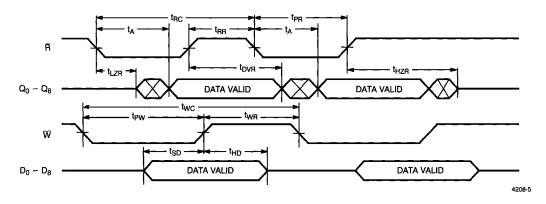
 t_{HZR} transition is measured at +500~mV from V_{OL} and -500~mV from V_{OH},t_{DVR} transition is measured at the 1.5V level. t_{HWZ} and t_{LZR} transition is measured at $\pm100~mV$ from the steady state.

 t_{HZR} and t_{DVR} use capacitance loading as in part (b) of AC Test Loads and Waveforms.

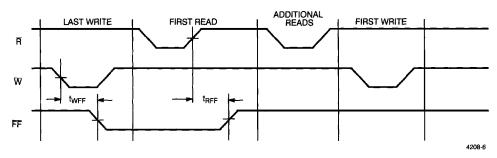


Switching Waveforms

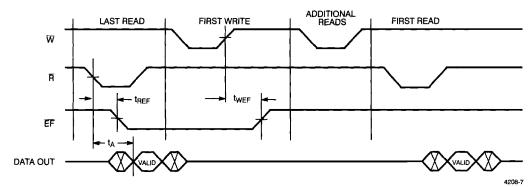
Aynchronous Read and Write Timing Diagram



Last Write to First Read Full Flag Timing Diagram

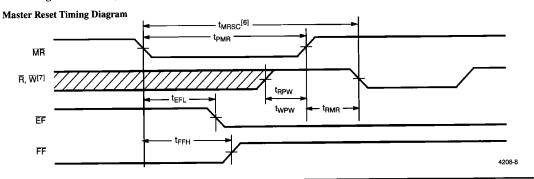


Last Read to First Write Empty Flag Timing Diagram

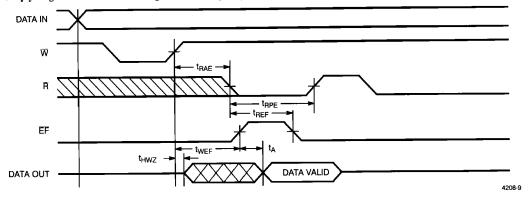




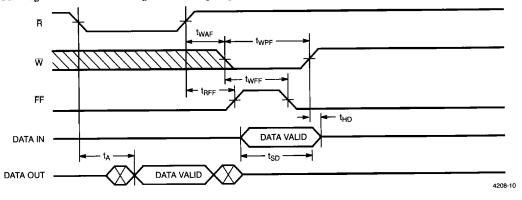
Switching Waveforms (continued)



Empty Flag and Read Bubble-Through Mode Timing Diagram



Full Flag and Write Bubble-Through Mode Timing Diagram



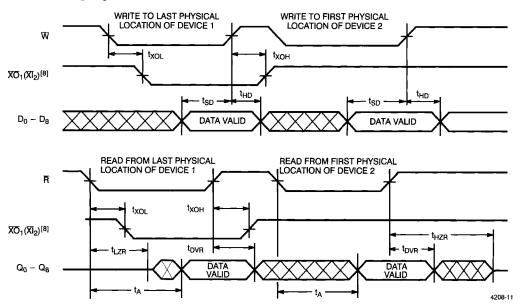
Notes:

- $t_{MRSC} = t_{PMR} + t_{RMR}$, $t_{RMR} = t_{RMR} + t_{RMR}$. W and $t_{RMR} = t_{RMR} + t_{RMR}$ or $t_{RMR} = t_{RMR} + t_{RMR}$.



Switching Waveforms (continued)

Expansion Timing Diagram



Note:

Expansion Out of Device 1 (\overline{XO}_1) is connected to Expansion In of Device 2 (\overline{XI}_2) .



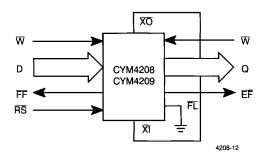


Figure 1. Single Device Mode

Architecture

The CYM4208 FIFO module is an array of 64K words of 9 bits each and is implemented using four 16Kx9 monolithic FIFOs. The CYM4209 is an array of 128K words of 9 bits each and is implemented using four 32K x 9 monolithic FIFOs. Each version has Full and Empty flags, but since the FIFOs are internally cascaded using the depth mode, the half full and retransmit features are not avail-

Pinouts of the CYM4208 and CYM4209 are compatible with industry standard 28-pin DIP. The functionality is compatible with monolithic FIFO devices and with other FIFO modules.

Resetting the FIFO

Upon power-up, the FIFO must be reset with a master reset (\overline{MR}) cycle. This causes the FIFO to enter the empty condition signified by the Empty flag (EF) being LOW and the Full flag (FF) resetting to HIGH. Read (R) and write (W) must be HIGH tRPW/tWPW before and t_{RMR} after the rising edge of MR for a valid reset cycle.

Writing Data to the FIFO

The availability of an empty location is indicated by the HIGH state of the Full flag (\overline{FF}). A falling edge of write (\overline{W}) initiates a write cycle. Data appearing at the inputs $(D_0 - D_8) t_{SD}$ before and tHD after the rising edge of W will be stored sequentially in the FIFO.

The Empty flag (EF) LOW-to-HIGH transition occurs twee after the first LOW-to-HIGH transition on the write clock of an empty FIFO. The Full flag (FF) goes LOW on the falling edge of W during the cycle in which the last available location in the FIFO is written, prohibiting overflow. FF goes HIGH tRFF after the completion of a valid read of a full FIFO.

Reading Data from the FIFO

The falling edge of read (\overline{R}) initiates a read cycle if the Empty flag (\overline{EF}) is not LOW. Data outputs $(Q_0 - Q_8)$ are in a high-impedance condition between read operations (R HIGH), when the FIFO is empty, or when the FIFO is in the depth expansion mode but is not the active device.

The falling edge of \overline{R} during the last read cycle before the empty condition triggers a HIGH-to-LOW transition of EF, prohibiting any further read operations until twee after a valid write.

Single Device Mode

Single device mode is entered by connecting FL to ground and connecting \overline{XO} to \overline{XI} (see Figure 1).

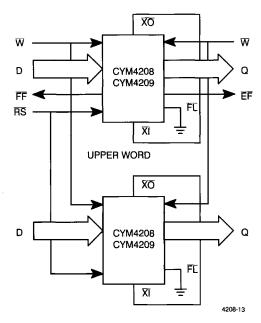


Figure 2. Width Expansion Mode

Width Expansion Mode

FIFOs can be expanded in width to provide word widths greater than 9 bits in increments of 9 bits. Devices are connected similar to the single device mode but with control line inputs in common to all devices. Flag outputs from any device can be monitored (see Figure 2).

Depth Expansion Mode

Depth expansion mode (see Figure 3) is entered when, during a MR cycle, expansion out (XO) of one device is connected to expansion in (\overline{XI}) of the next device, with \overline{XO} of the last device connected to \overline{XI} of the first device. In the depth expansion mode the first load (FL) input, when grounded, indicates that this part is the first to be loaded. All other devices must have this pin HIGH. To enable the correct FIFO, XO is pulsed LOW when the last physical location of the previous FIFO is written to and is pulsed LOW again when the last physical location is read. Only one FIFO is enabled for read and one is enabled for write at any given time. All other devices are in standby.

FIFOs can also be expanded simultaneously in depth and width. Consequently, any depth or width FIFO can be created of word widths in increments of 9 bits. When expanding in depth, a composite FF and EF must be created by ORing the FFs together and the EFs together.



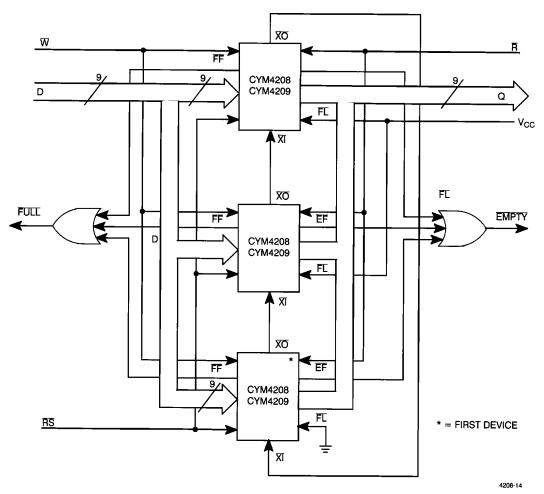


Figure 3. Depth Expansion Mode



Ordering Information

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
25	CYM4208HD-25C	HD10	28-Pin Ceramic DIP Module	Commercial
30	CYM4208HD-30C	HD10	28-Pin Ceramic DIP Module	Commercial
ļ	CYM4208HD-30MB	HD10	28-Pin Ceramic DIP Module	Military
40	CYM4208HD-40C	HD10	28-Pin Ceramic DIP Module	Commercial
	CYM4208HD-40MB	HD10	28-Pin Ceramic DIP Module	Military

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
25	CYM4209HD-25C	HD10	28-Pin Ceramic DIP Module	Commercial
30	CYM4209HD-30C	HD10	28-Pin Ceramic DIP Module	Commercial
	CYM4209HD-30MB	HD10	28-Pin Ceramic DIP Module	Military
40	CYM4209HD-40C	HD10	28-Pin Ceramic DIP Module	Commercial
	CYM4209HD-40MB	HD10	28-Pin Ceramic DIP Module	Military

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